

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination SUNAGA ET AL.	
		Examiner	Art Unit	Page 1 of 1
		Dang T Nguyen	2824	

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0231523 A1	12-2003	Cho et al.	365/189.05
*	B	US-2003/0142566 A1	07-2003	Sohn et al.	365/201
*	C	US-2003/0210604 A1	11-2003	Jeong et al.	365/233
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